

Stress Ratio Influence on da/dN with the Generalized Willenborg Model

Updated Material Data & Fitting Process

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Acknowledgements

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- Dr. Mike Blinn
- Chad King

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- Lucky Smith



http://californiasciencecenter.org/sites/default/files/styles/meta/public/media/image/northrop-t-38-talon.jpeg?itok=xTHR_qSd

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Agenda

- ❑ Background
- ❑ Approach
- ❑ Test Matrix
- ❑ Material Fitting Process
- ❑ Re-Correlation of SOLR
- ❑ Updated Life Predictions
- ❑ Conclusions



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Background

- ❑ Previous studies by T-38 Analysis (Chad King, others) characterized typical T-38 spectra and the associated $R_{\text{effective}}$ based on the utilization of the Generalized Willenborg Retardation model
- ❑ Study indicated $R_{\text{effective}}$ was predominantly negative
 - Minimal existing crack growth rate data for $R < 0$
- ❑ Recommendations from this study included:
 - Complete additional crack growth rate testing at $R < 0$
 - Compare to existing “extrapolated material model”
 - Revisit R_{lo}
 - Re-correlate crack growth rate data
 - Sensitivity study of select FCLs to understand impact

Background

Generalized Willenborg Model

- Adjusts da/dN by reducing R to R_{eff}

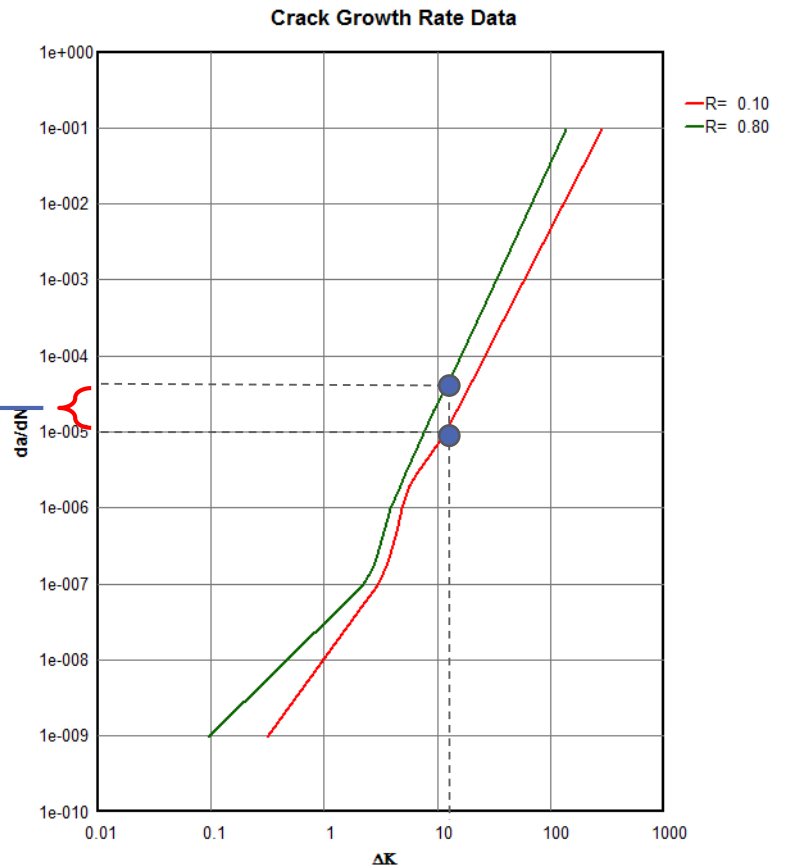
$$K_r = \frac{1 - \frac{\Delta K_{th}}{K_{max}}}{(SOLR - 1)} \left[K_{OL} \sqrt{1 - \frac{x - x_{OL}}{r_{OL}}} - K_{max} \right]$$

$$K_{min,eff} = K_{min} - K_r$$

$$K_{max,eff} = K_{max} - K_r$$

$$R_{eff} = \frac{K_{min,eff}}{K_{max,eff}}$$

Retardation Effect:
Reduction in da/dN



Note: For $R < 0.0$, K_{max} is used instead of Delta K

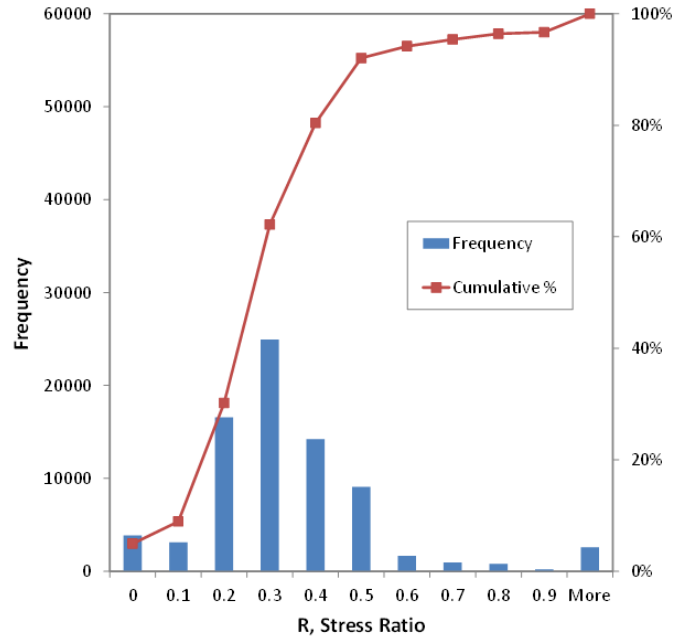
Ref: Lessons Learned: Stress Ratio Influence on da/dN when using the Generalized Willenborg Model, Chad King, AFGROW Workshop 2015.

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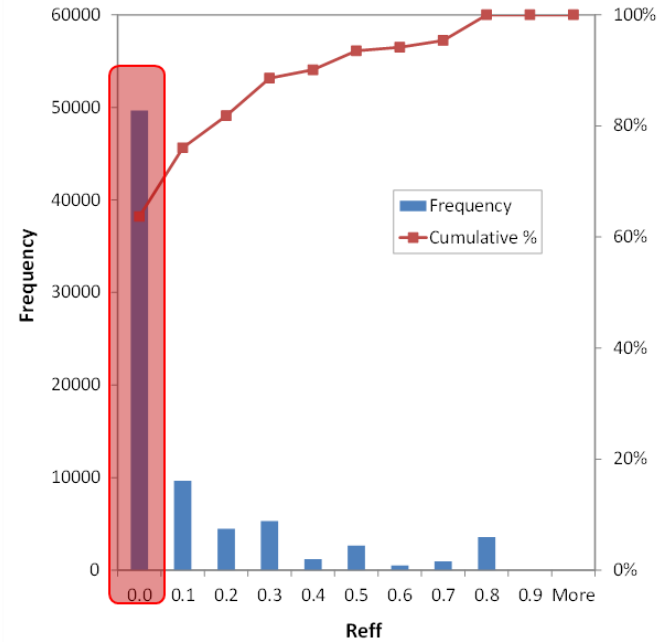
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Background

FCL A-1-29 IFF Usage



R , Stress Ratio



R_{eff} , Effective Stress Ratio

1st 1000 hours

Ref: Lessons Learned: Stress Ratio Influence on da/dN when using the Generalized Willenborg Model, Chad King, AFGROW Workshop 2015.

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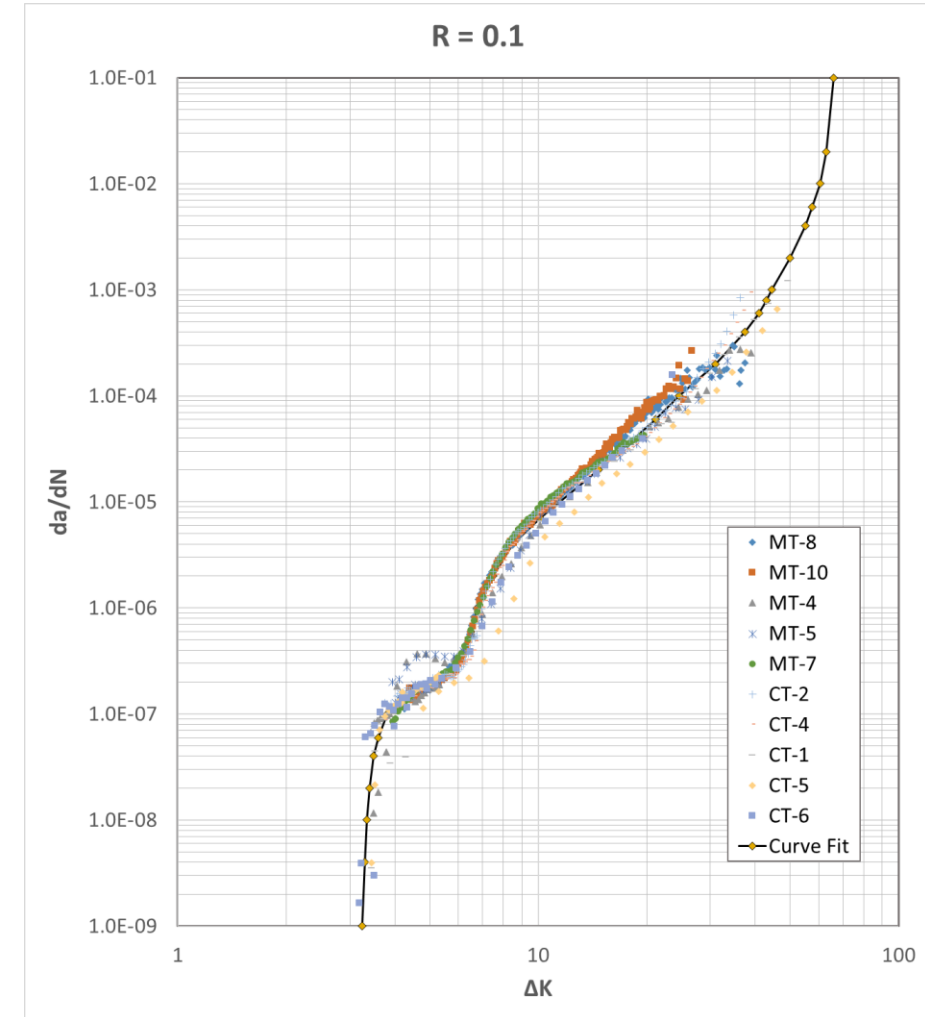
Approach

- ❑ Identify necessary negative R data
- ❑ Complete new Fatigue Crack Growth Rate (FCGR) testing
- ❑ Re-correlate tabular lookup files
 - Initial focus - 7075-T7351, 7475-T7351
 - Incorporate new test data
 - Follow disciplined material fitting process
- ❑ Select (2) FCLs (A-10a, A-15):
 - Re-correlate SOLRs
 - Recalculate damage tolerance life
- ❑ Characterize impacts of negative R data and new fitting process
- ❑ Provide recommendations

| Material | Stress Ratios |
|-------------|---|
| 7075-T7351 | R=0.5, 0.1, 0.05, -0.3, -0.5, -1.0 |
| 7475-T7351 | R=0.8, 0.5, 0.1, 0.05, -0.3, -0.5, -1.0 |
| 4330M | R=0.1 |
| 4130 | R=0.7, -0.2, -0.5 |
| 7075-T73511 | R=-0.2, -0.5 |

Material Fitting Process

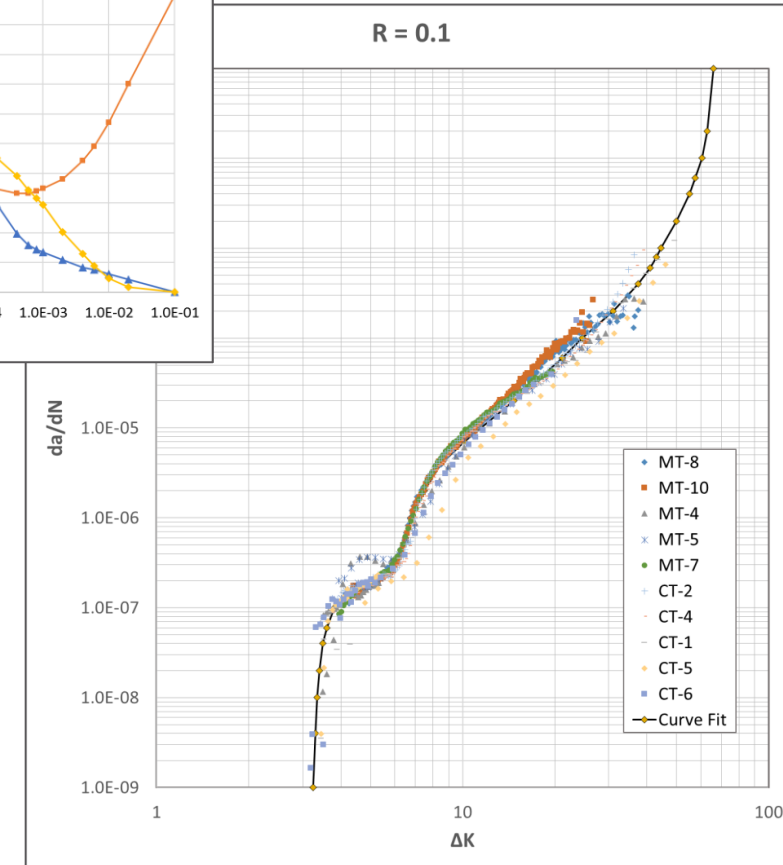
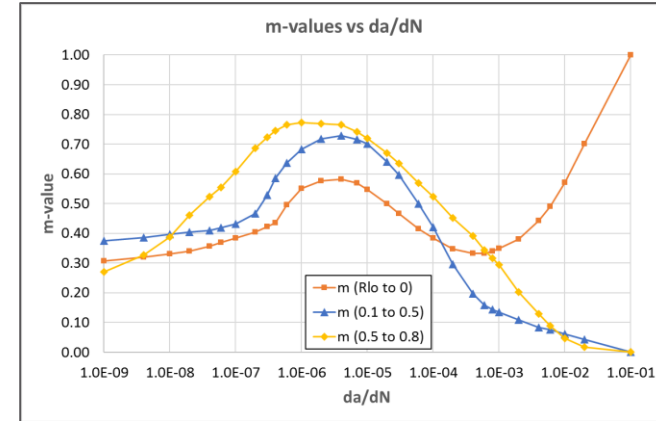
- ❑ Discipline process presented at AFGROW training courses
- ❑ Based on Harter-T method
 - Shifts da/dN curves for any R
 - Applies Walker Equation (point-by-point basis)
- ❑ General process:
 - Step 1: Initial fit of data at each R
 - Step 2: Calculate Walker equation “ m ” values
 - Step 3: Define max ΔK for each R
 - Step 4: Smooth m curves for positive R values
 - Step 5: Fit negative R data & determine R_{lo}



Material Fitting Process

□ General process:

- Step 1: Initial fit of data at each R
- Step 2: Calculate Walker equation “m” values
 - Based on Harter-T method and plot for adjacent R values
 - See AFGROW users manual for additional info
- Step 3: Define max ΔK for each R
 - ΔK at R=0 should match K_c as long as coupon is in plane stress
 - Other ΔK max values = $(1-R)*K_c$
- Step 4: Smooth m curves for positive R values
 - Work from smallest to largest R
 - Priority - (1) match data, (2) smooth m, (3) similar m-curve shapes
 - Positive R m-curves must trend to 0 at highest da/dN



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Material Fitting Process

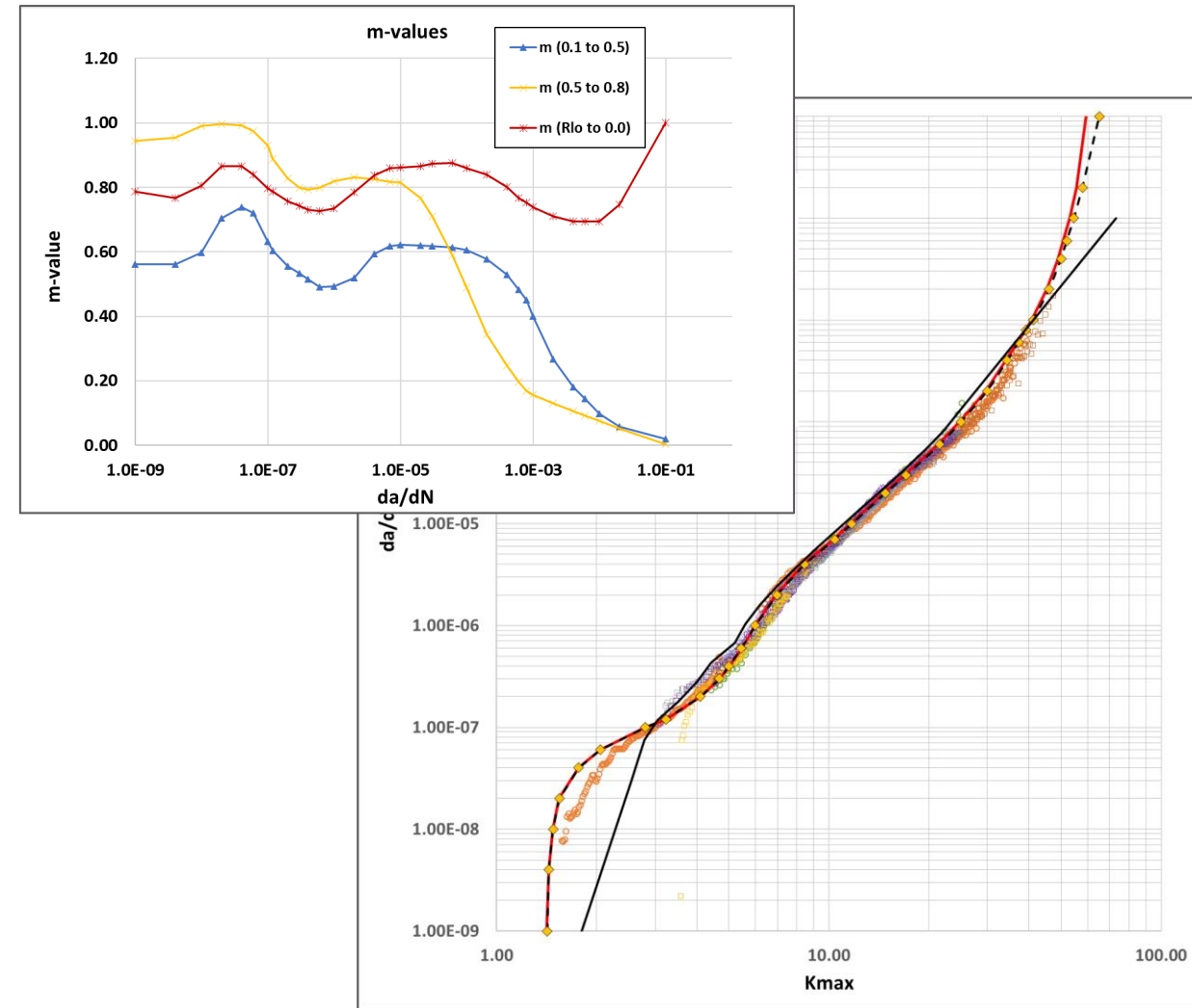
□ General process:

➤ Step 5: Fit negative R data & determine R_{lo}

- Fit negative R data
- Generate negative R curve based on m-values from adjacent positive R
- Adjust R until the shifted curve matched the fit of the negative R data
 - The resulting R is the R_{lo} value

➤ General rules:

- R_{lo} must go to R=0 curve at highest point
- Positive R curves cannot cross each other
- R_{hi} is typically 0.7-0.8
- Negative R shift relative to R=0 must be less than the shift for the same positive R



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Material Fitting Process

Walker Equation:

$$da/dN = C[\Delta K(1-R)^{(m-1)}]^n$$

At a given da/dN , the relationship reduces to:

$$\Delta K = \Delta K(R=0)(1-R)^{(1-m)}, \text{ For } R \geq 0.0$$

$$\Delta K = \Delta K(R=0)(1-R)^{(m-1)}, \text{ For } R < 0.0 - \text{ Note: Here, } \Delta K \text{ is } K_{max}$$

Although not algebraically correct, it is important that the proper trend in **R** shift be maintained. This trend is that as **m** increases, the **R** shift decreases.

Note, that this method is simply a way to interpolate/extrapolate data in log-log scale by using the exponential form. This method has given very good results over the years.

Since $da/dN = C[\Delta K(1-R)^{(m-1)}]^n$, (Walker equation)

At a given da/dN , data at any two positive **R**-values becomes:

$$\Delta K_1(1-R_1)^{(m-1)} = \Delta K_2(1-R_2)^{(m-1)}$$

Solving for **m** yields:

$$m = 1 + \left[\frac{\log_{10}(\Delta K_1 / \Delta K_2)}{\log_{10}((1-R_2)/(1-R_1))} \right]$$

For the reasons stated in the Harter T-Method reference the method to handle negative stress ratios simply involves switching the exponent for the negative **R** as follows:

$$\Delta K_1(1-R_1)^{(1-m)} = \Delta K_2(1-R_2)^{(m-1)}, \text{ Where } R_1 \text{ is negative and } R_2 \text{ is positive}$$

Solving for **m** yields:

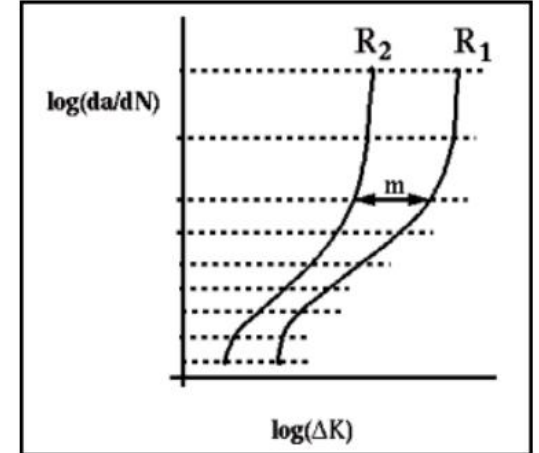
$$m = 1 + \left[\frac{\log_{10}(\Delta K_1 / \Delta K_2)}{\log_{10}((1-R_1)(1-R_2))} \right]$$

For two negative **R** values, the relationship becomes:

$$\Delta K_1(1-R_1)^{(1-m)} = \Delta K_2(1-R_2)^{(1-m)}$$

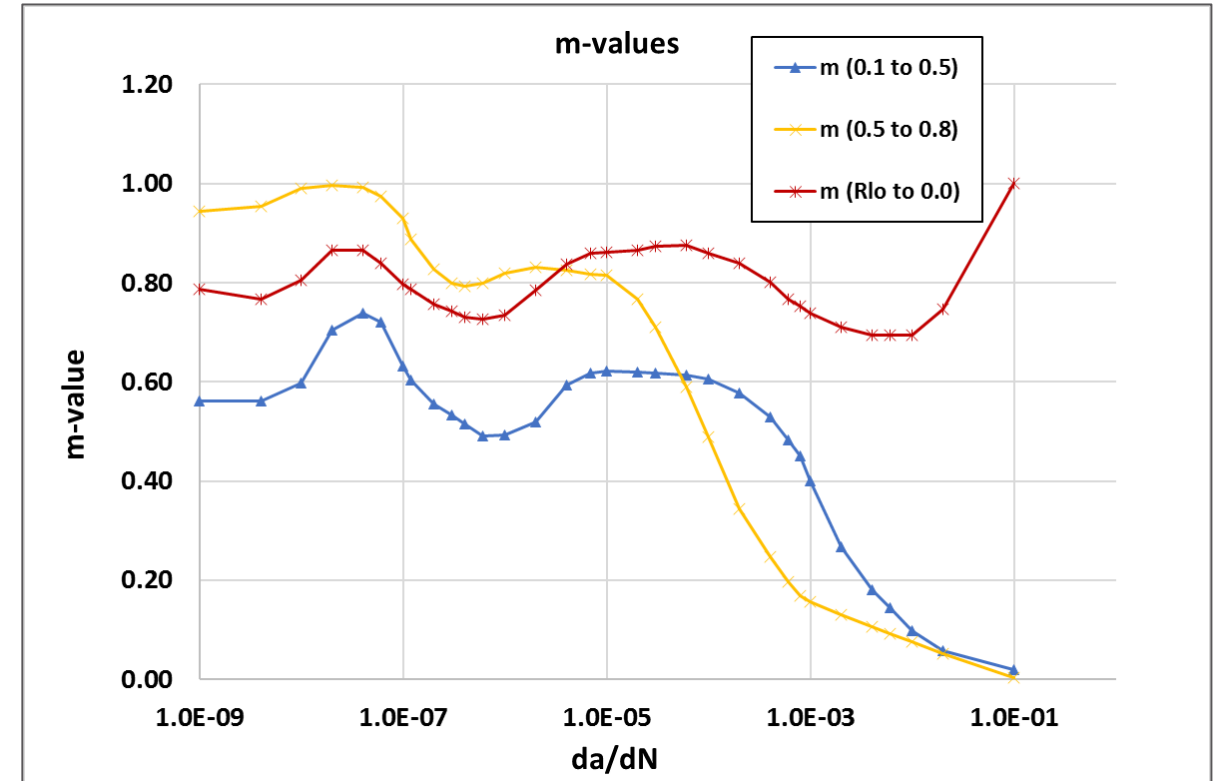
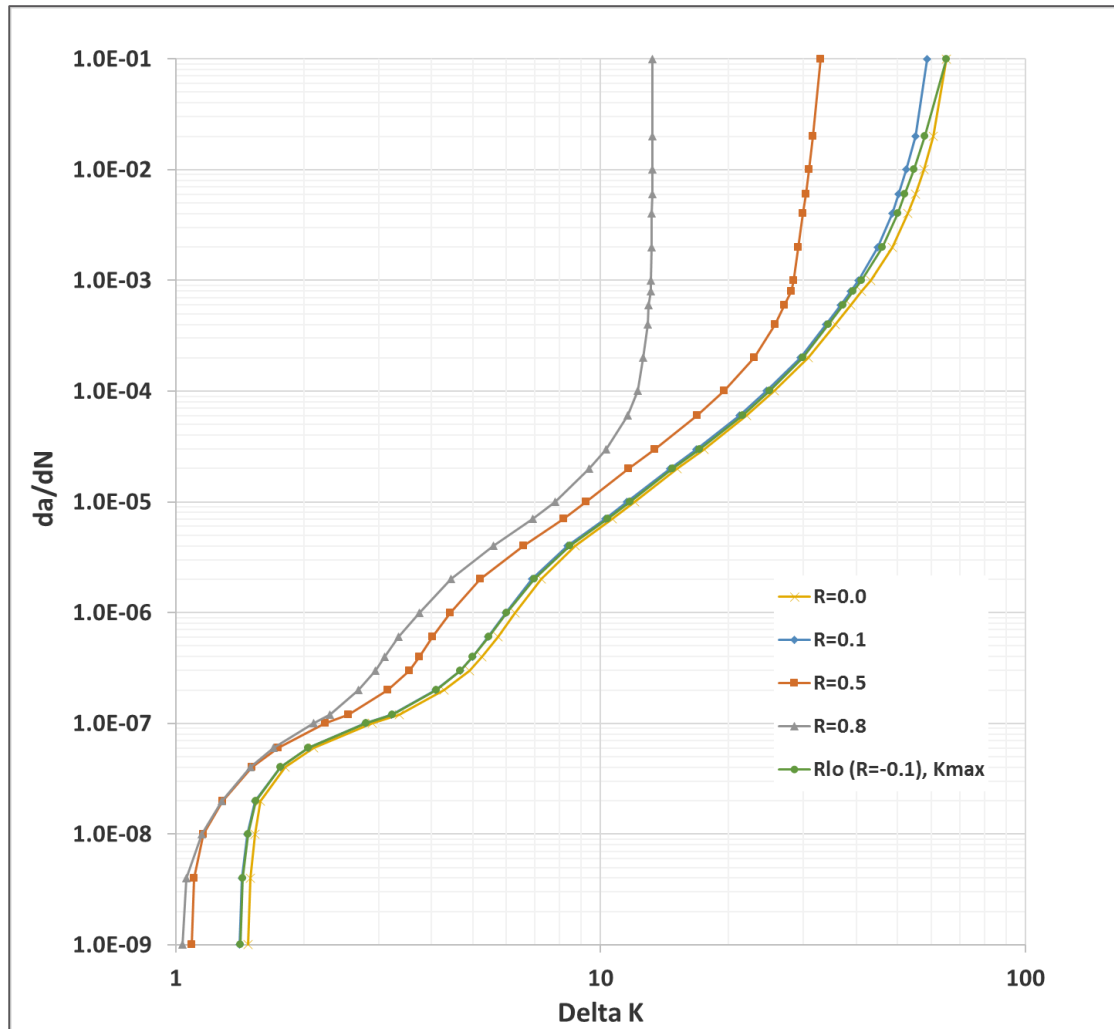
Solving for **m** yields:

$$m = 1 - \left[\frac{\log_{10}(\Delta K_1 / \Delta K_2)}{\log_{10}((1-R_2)/(1-R_1))} \right]$$



- **m** is NOT the slope of anything of interest
- **m** is NOT a distance or stress intensity
- **m** has no dimensions
- **m** is not part of the candy team that melts in your mouth, not in your hand
- The value of **m** is merely a mathematical means of controlling the shift of the crack growth rate data as a function of stress ratio (**R**)

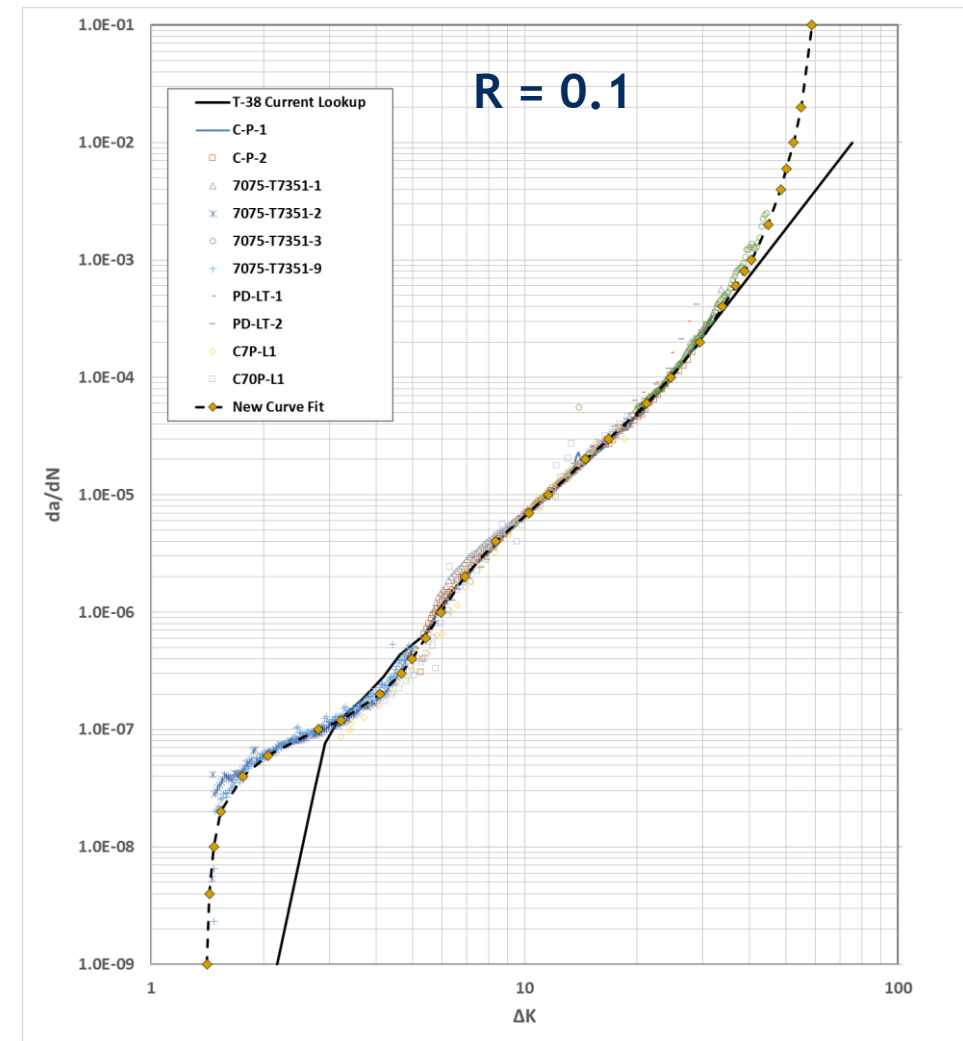
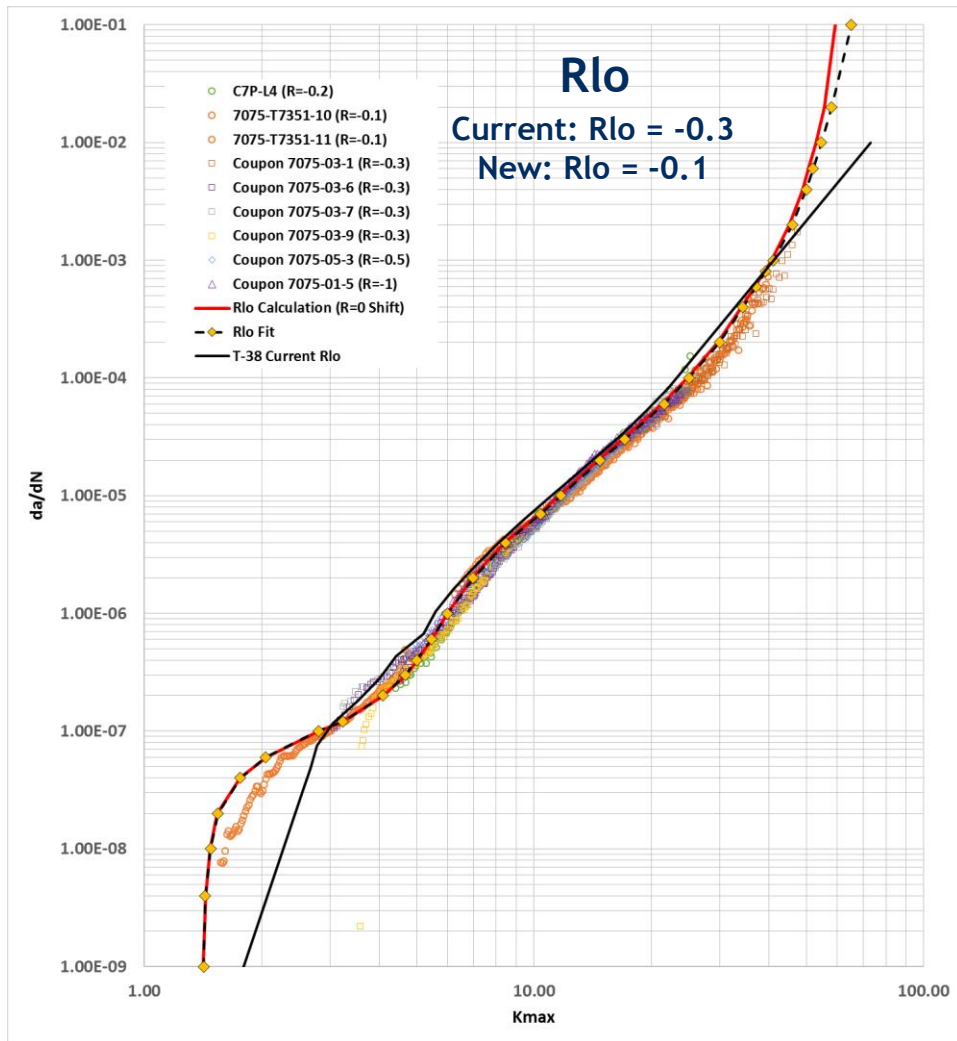
Material Fitting Process



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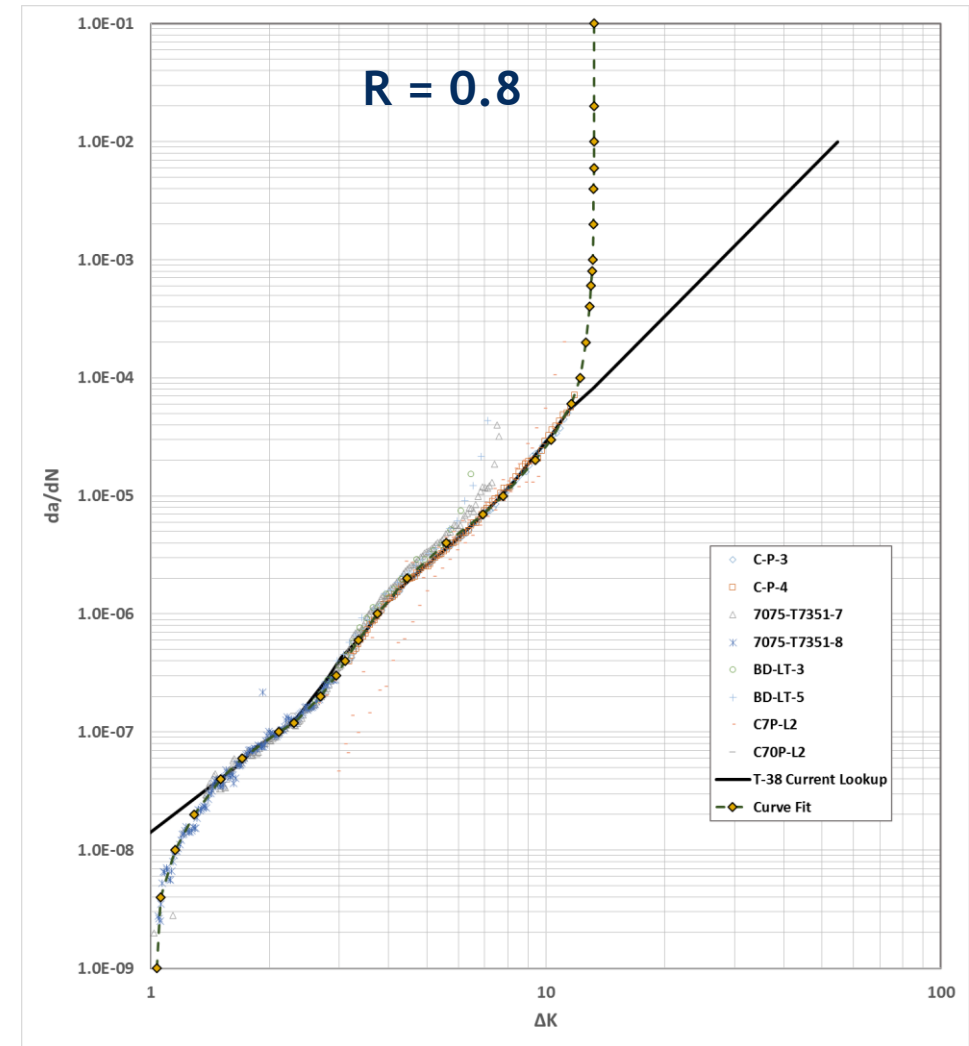
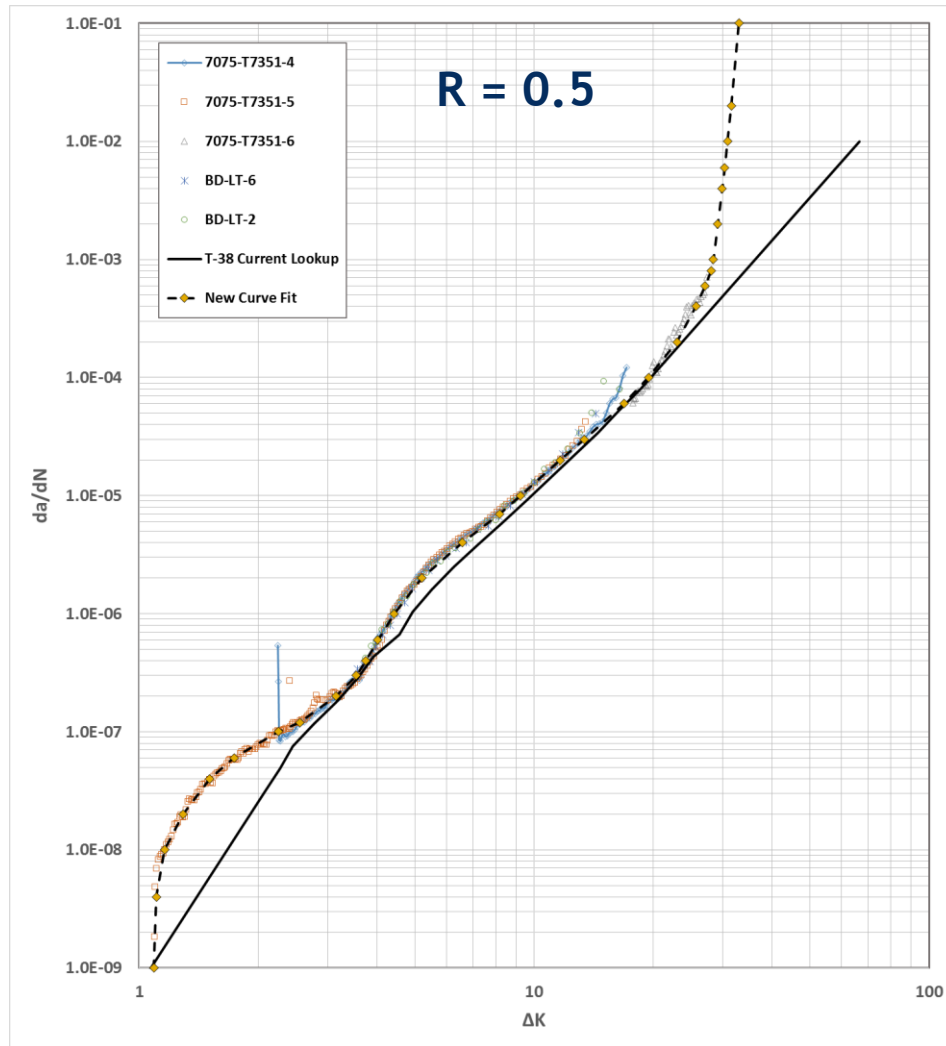
7075-T7351 Material Fit



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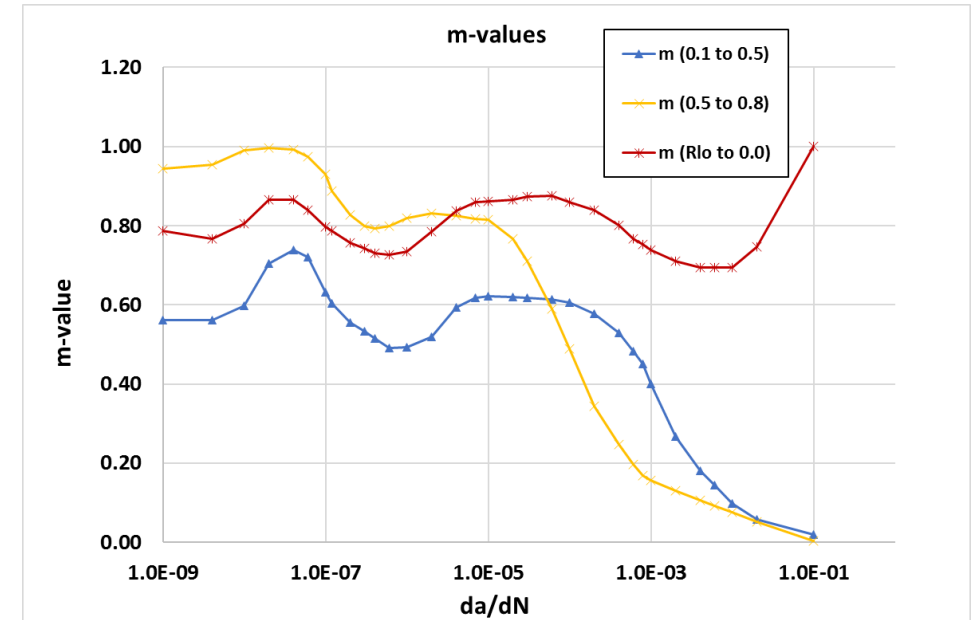
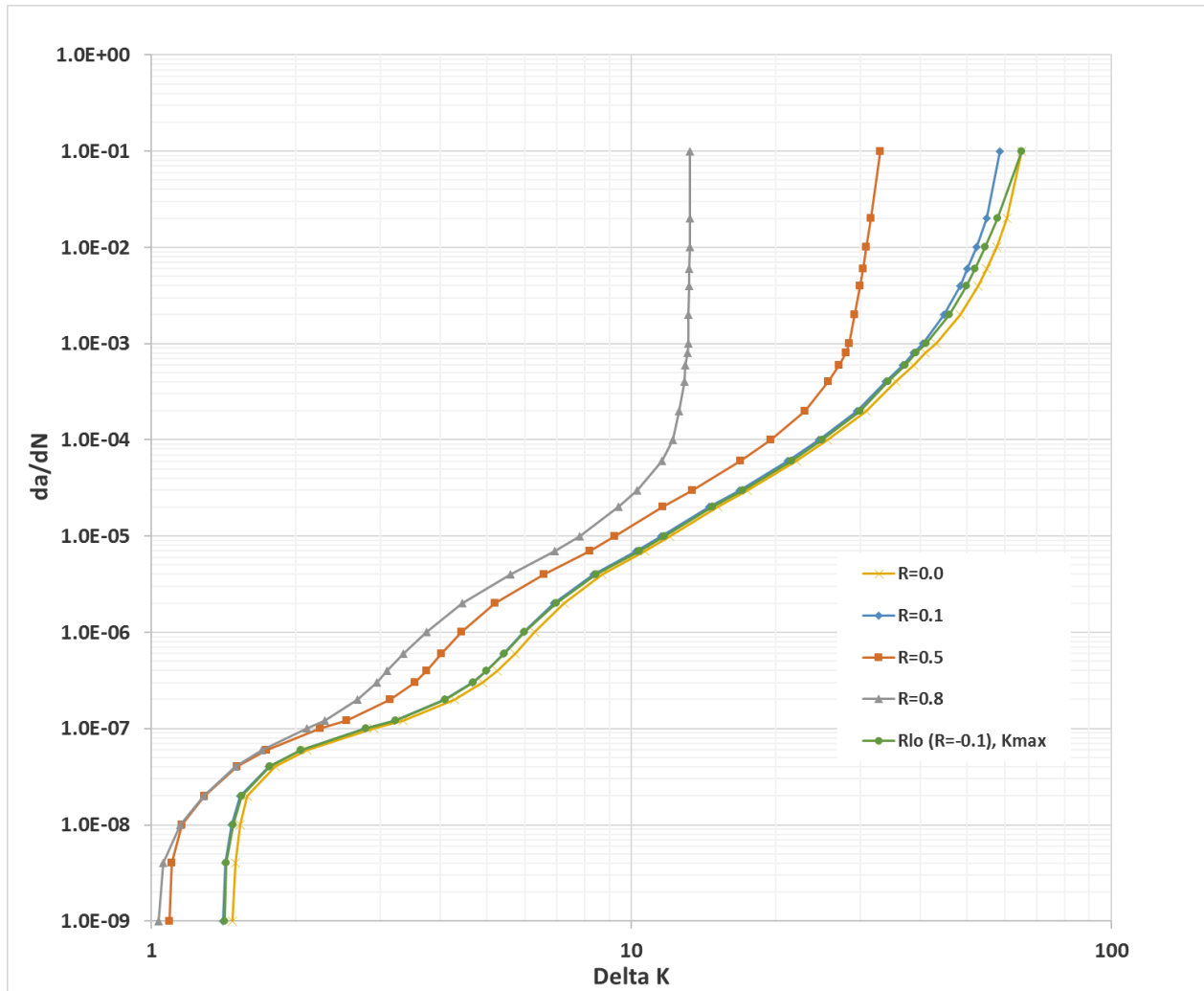
7075-T7351 Material Fit



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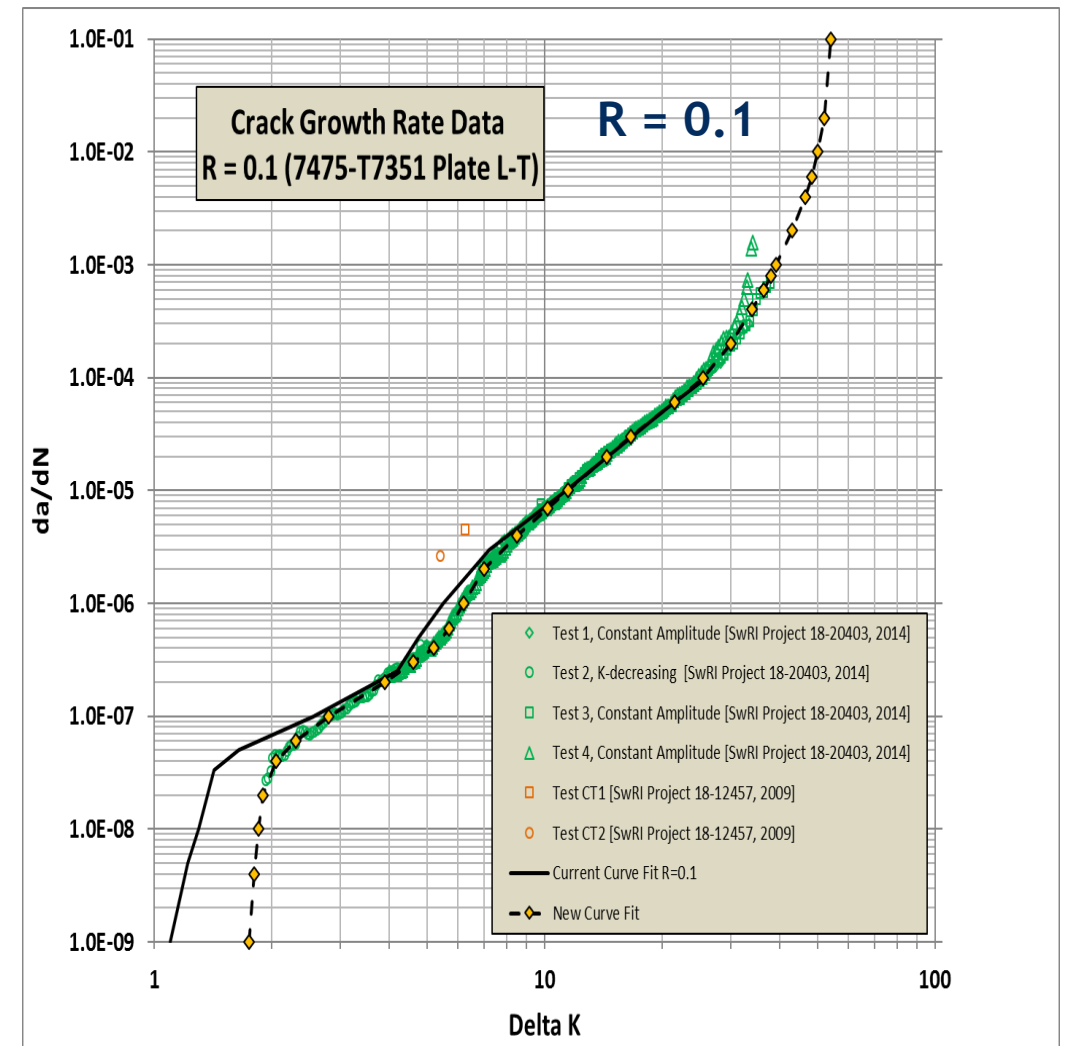
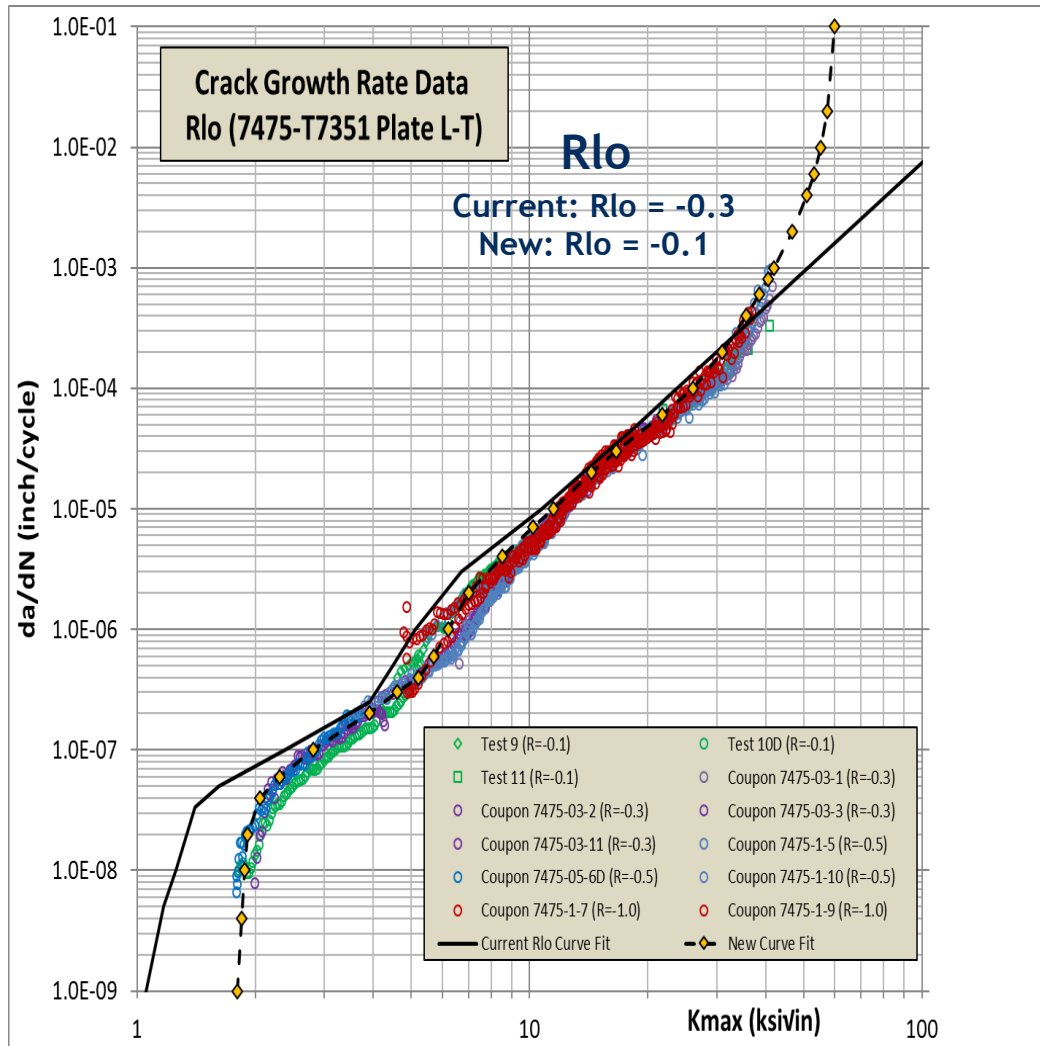
7075-T7351 Material Fit



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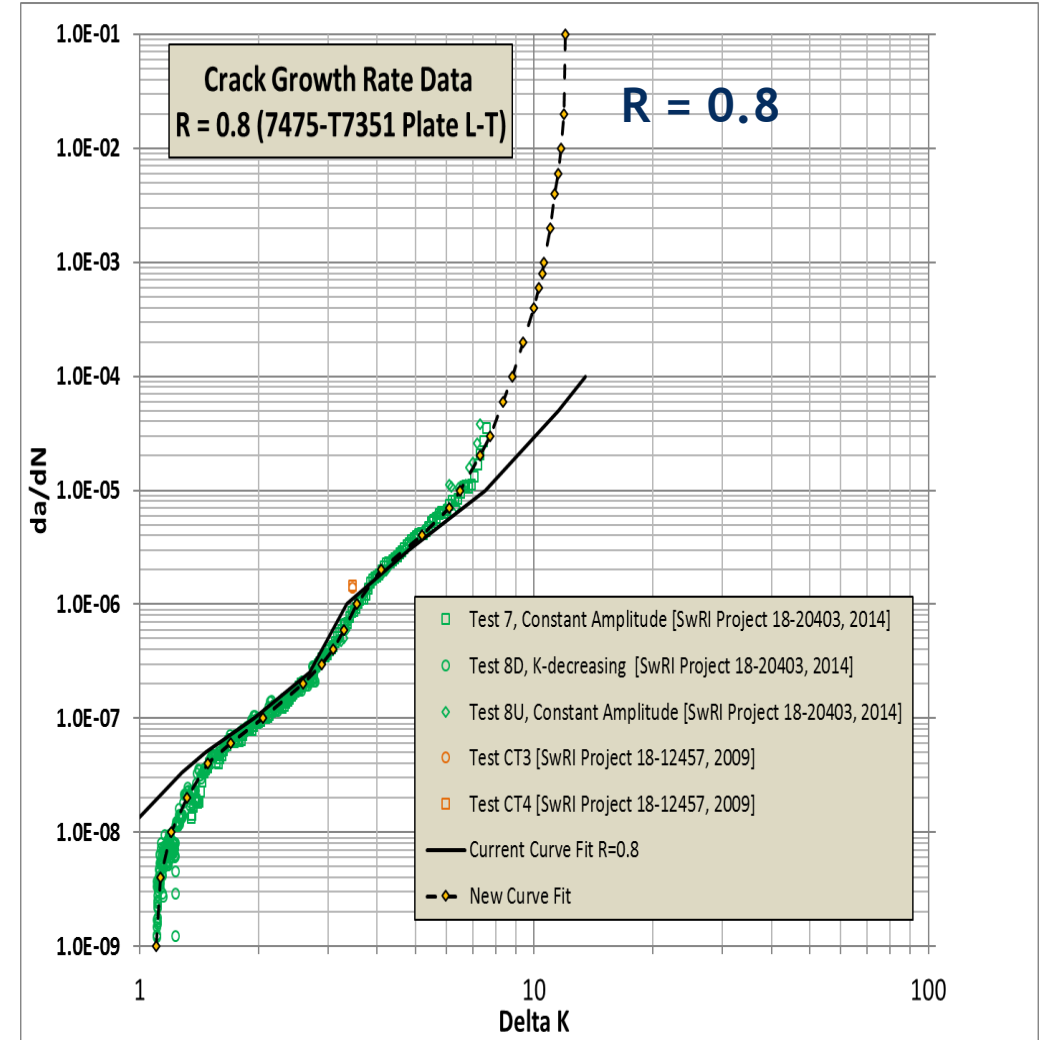
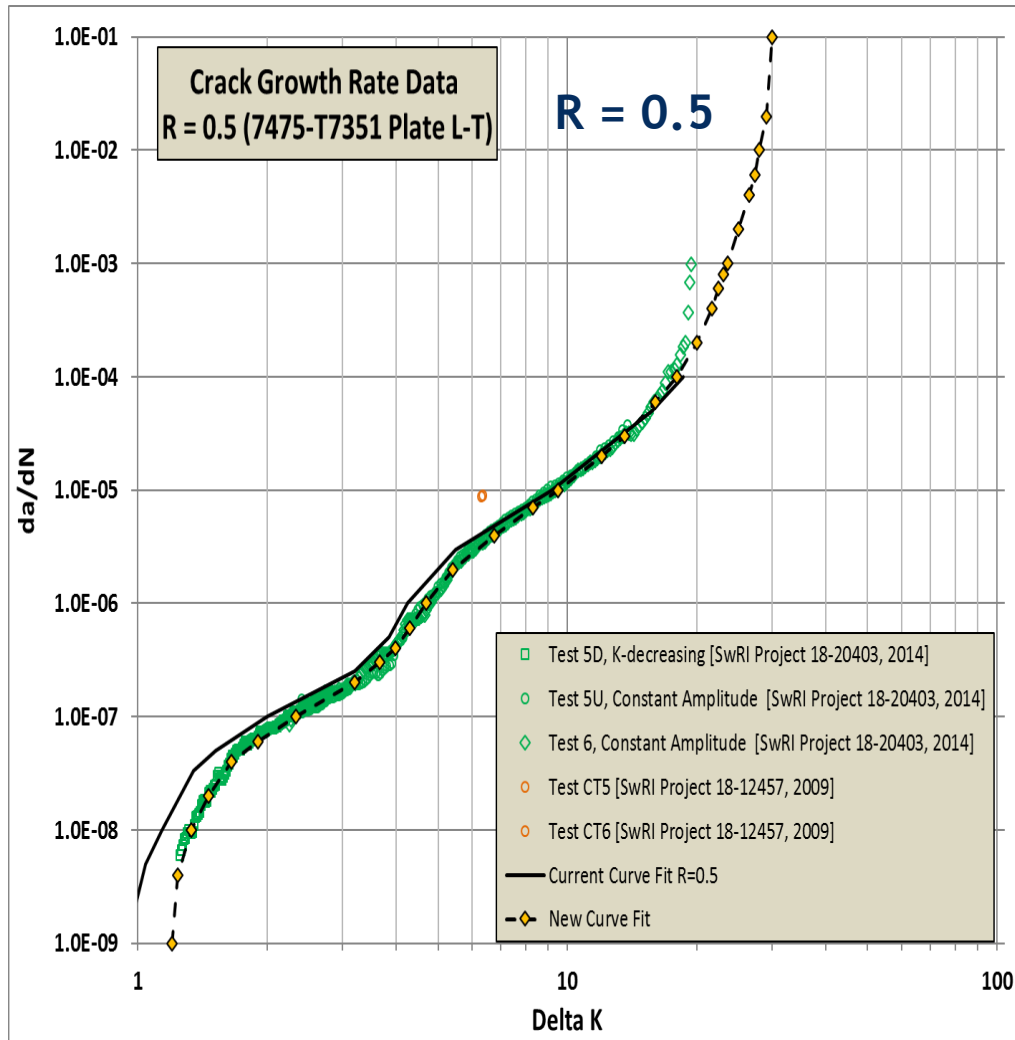
7475-T7351 Material Fit



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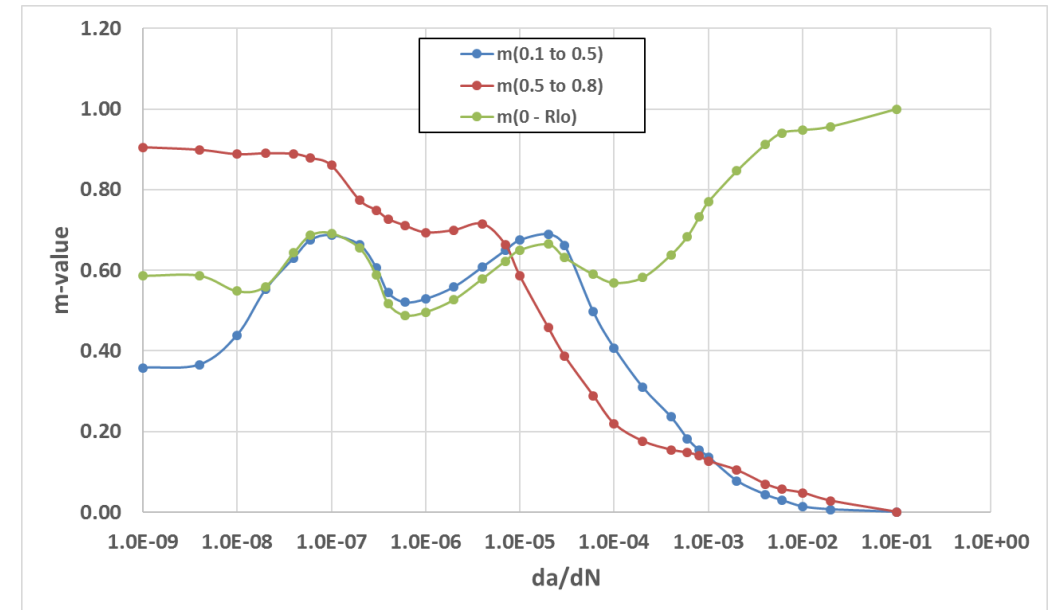
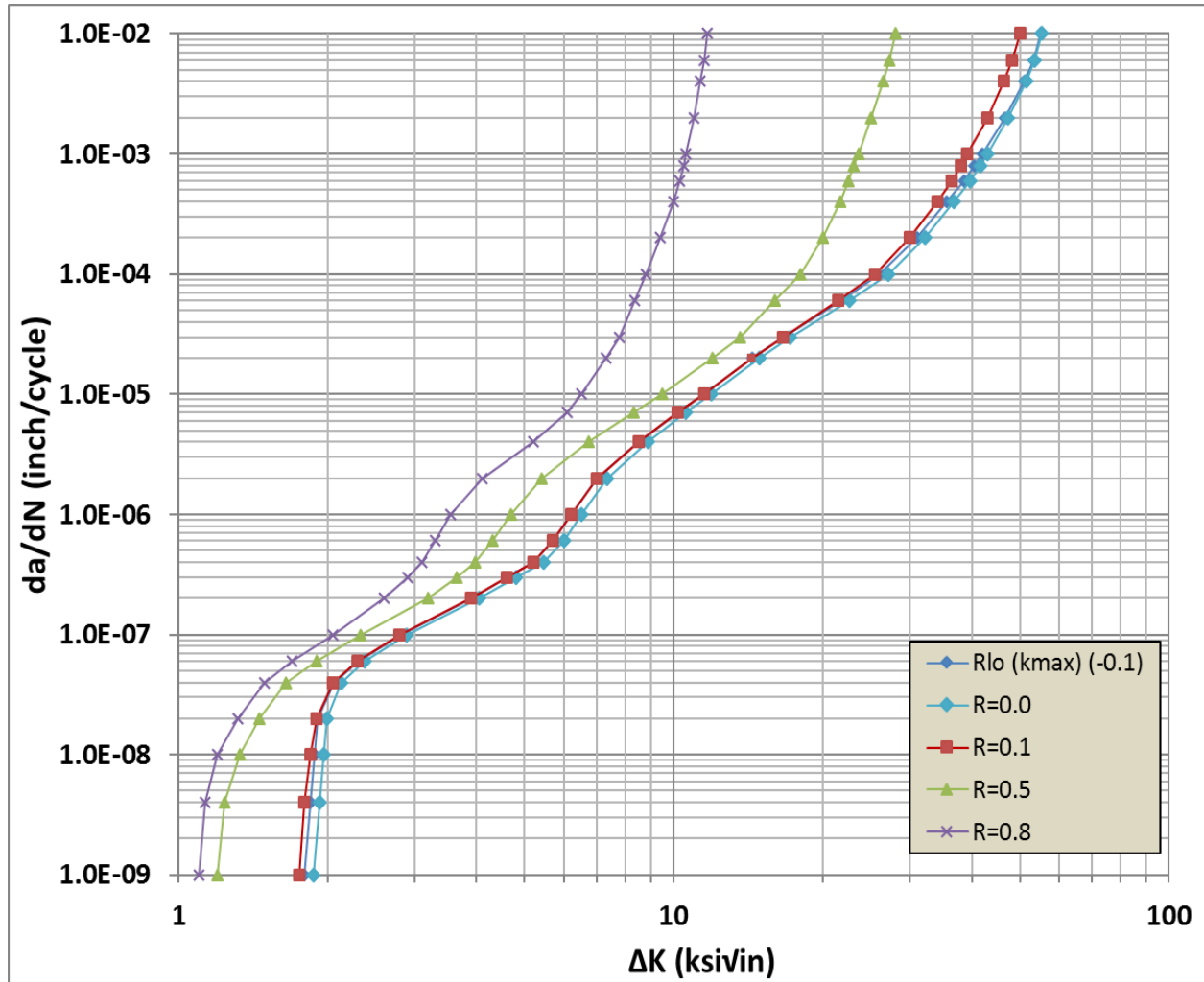
7475-T7351 Material Fit



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7475-T7351 Material Fit



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7075-T7351, Overall Summary

| FCL | Material | Specimen ID | Usage | SOLR CORRELATION DETAILS | | | | | | CRACK GROWTH LIFE RESULTS | |
|----------|------------------|-------------|-------|--------------------------|-------------------|--------------------------------|-------------------|----------------------|-------------------|---------------------------|---------|
| | | | | ORIGINAL ANALYSIS | | UPDATED MATERIAL FIT + -R DATA | | NEGATIVE R DATA ONLY | | UPDATED MATERIAL + -R | -R ONLY |
| | | | | Correlated SOLR | SOLR for Analysis | Correlated SOLR | SOLR for Analysis | Correlated SOLR | SOLR for Analysis | | |
| A-10a-29 | 7075-T7351 plate | P-A10A-1 | IFF | 2.50 | 2.5 | 2.65 | 2.65 | N/A | N/A | 105% | N/A |
| | | P-A10A-2 | | 1.85 | | 1.95 | | | | | |
| | | P-A10A-3 | | 1.83 | | 1.91 | | | | | |
| | | P-A10A-4 | SUPT | 2.23 | 2.3 | 2.36 | 2.36 | 2.3 | 2.30 | 116% | 110% |
| | | P-A10A-5 | | 2.12 | | 2.24 | | 2.18 | | | |
| | | P-A10A-6 | | 2.35 | | 2.47 | | 2.42 | | | |
| A-15-29 | 7075-T7351 plate | P-A15-1 | IFF | 2.4 | 2.35 | 2.6 | 2.56 | N/A | N/A | 100% | N/A |
| | | P-A15-2 | | 2.2 | | 2.35 | | | | | |
| | | P-A15-3 | | 2.35 | | 2.56 | | | | | |
| | | P-A15-4 | SUPT | 2.4 | 2.6 | 2.65 | 2.91 | 2.47 | 2.68 | 95% | 106% |
| | | P-A15-5 | | 2.3 | | 2.47 | | 2.36 | | | |
| | | P-A15-6 | | 2.6 | | 2.91 | | 2.68 | | | |

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7475-T7351, Overall Summary

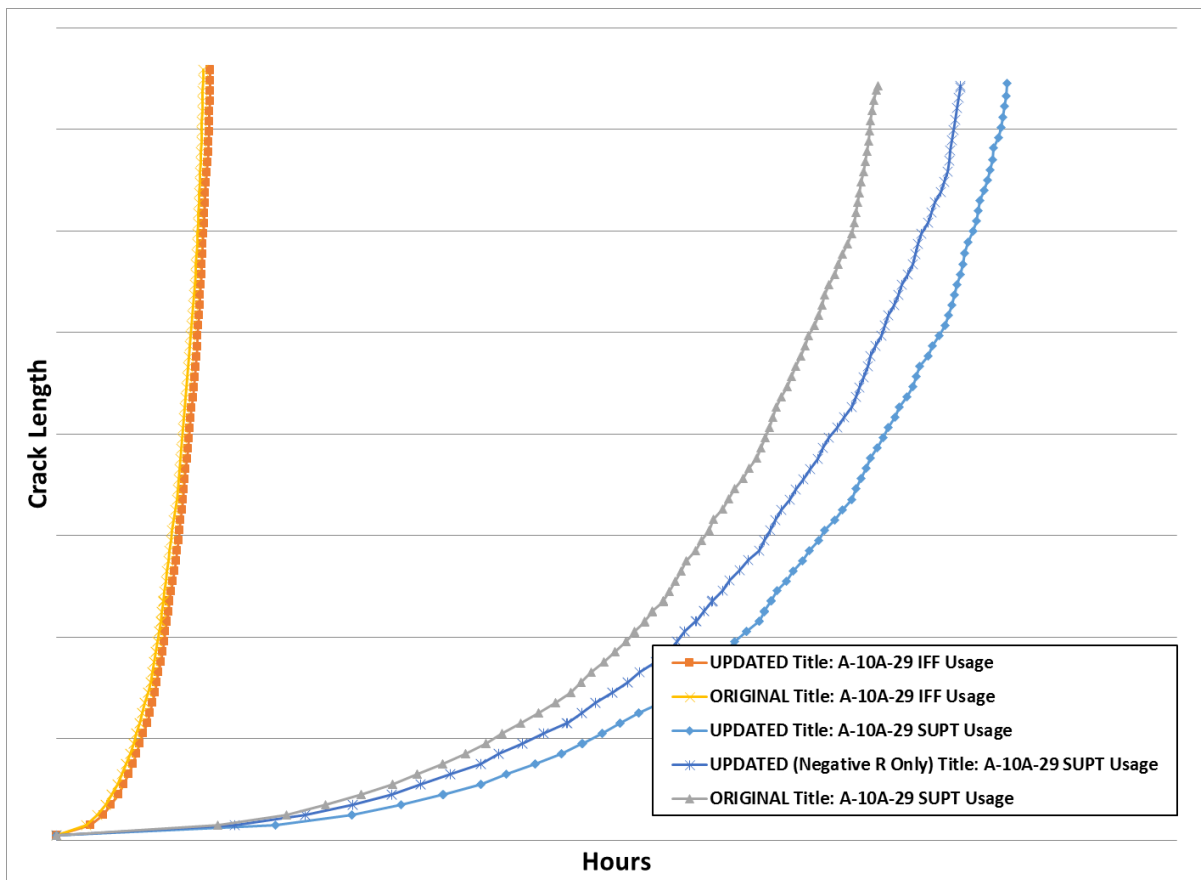
| FCL | Material | Specimen ID | Usage | SOLR CORRELATION DETAILS | | | | CRACK GROWTH LIFE RESULTS |
|----------|------------------|-------------|-------|--------------------------|-------------------|--------------------------------|-------------------|---------------------------|
| | | | | ORIGINAL ANALYSIS | | UPDATED MATERIAL FIT + -R DATA | | UPDATED MATERIAL + -R |
| | | | | Correlated SOLR | SOLR for Analysis | Correlated SOLR | SOLR for Analysis | |
| A-10a-33 | 7475-T7351 plate | A10a-7475-1 | IFF | 1.94 | 1.94 | 2.01 | 1.99 | 94% |
| | | A10a-7475-2 | | 1.91 | | 1.99 | | |
| | | A10a-7475-3 | | 1.93 | | 1.99 | | |
| | | A10a-7475-4 | SUPT | 2.14 | 2.19 | 2.21 | 2.24 | |
| | | A10a-7475-5 | | 2.12 | | 2.18 | | |
| | | A10a-7475-6 | | 2.19 | | 2.24 | | |
| | | A10a-7475-7 | | 2.16 | | 2.22 | | |
| A-15-33 | 7475-T7351 plate | A15-7475-1 | IFF | 1.73 | 1.79 | 1.76 | 1.83 | 94% |
| | | A15-7475-2 | | 1.76 | | 1.79 | | |
| | | A15-7475-3 | | 1.79 | | 1.83 | | |
| | | A15-7475-4 | SUPT | 2.03 | 2.03 | 2.08 | 2.08 | |
| | | A15-7475-5 | | 1.99 | | 2.04 | | |
| | | A15-7475-6 | | 2.03 | | 2.07 | | |

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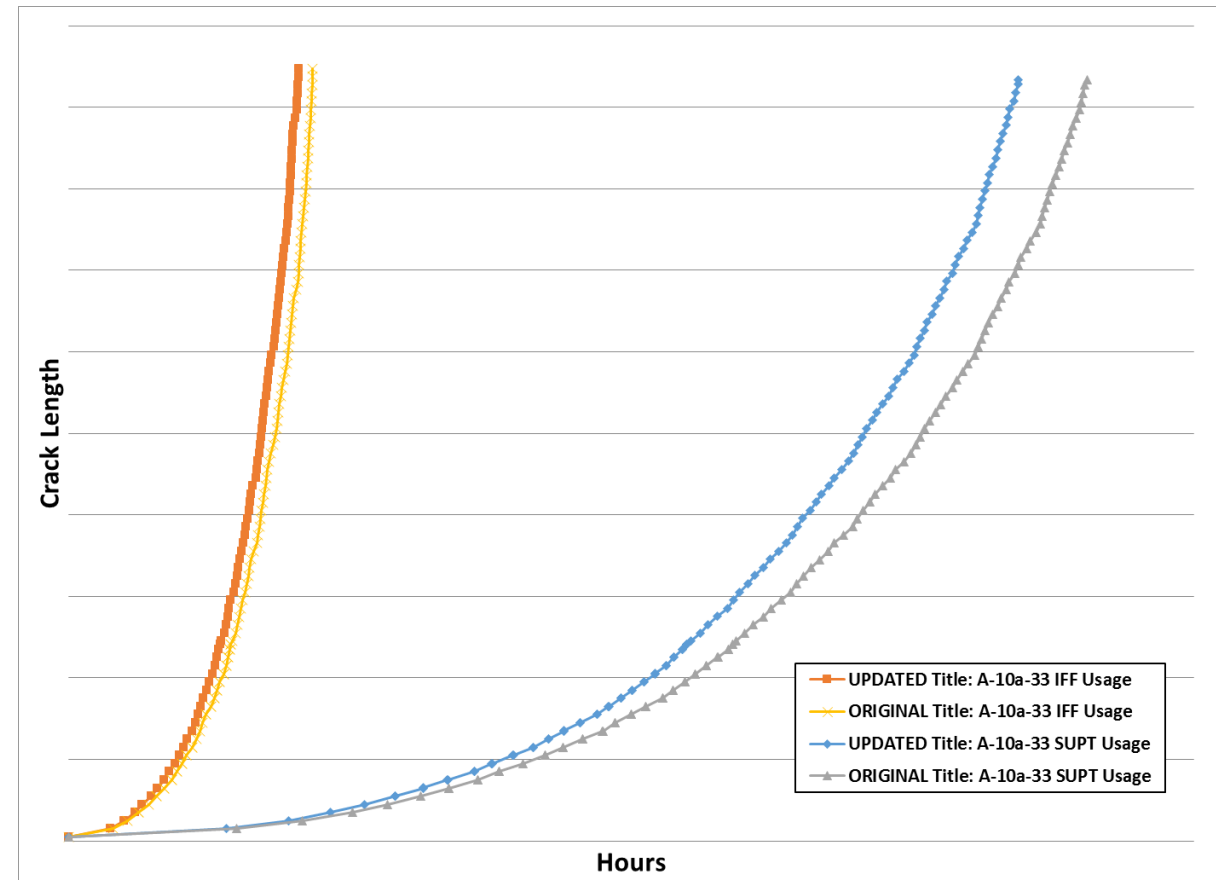
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A-10a Crack Growth Plot

A-10a-29



A-10a-33

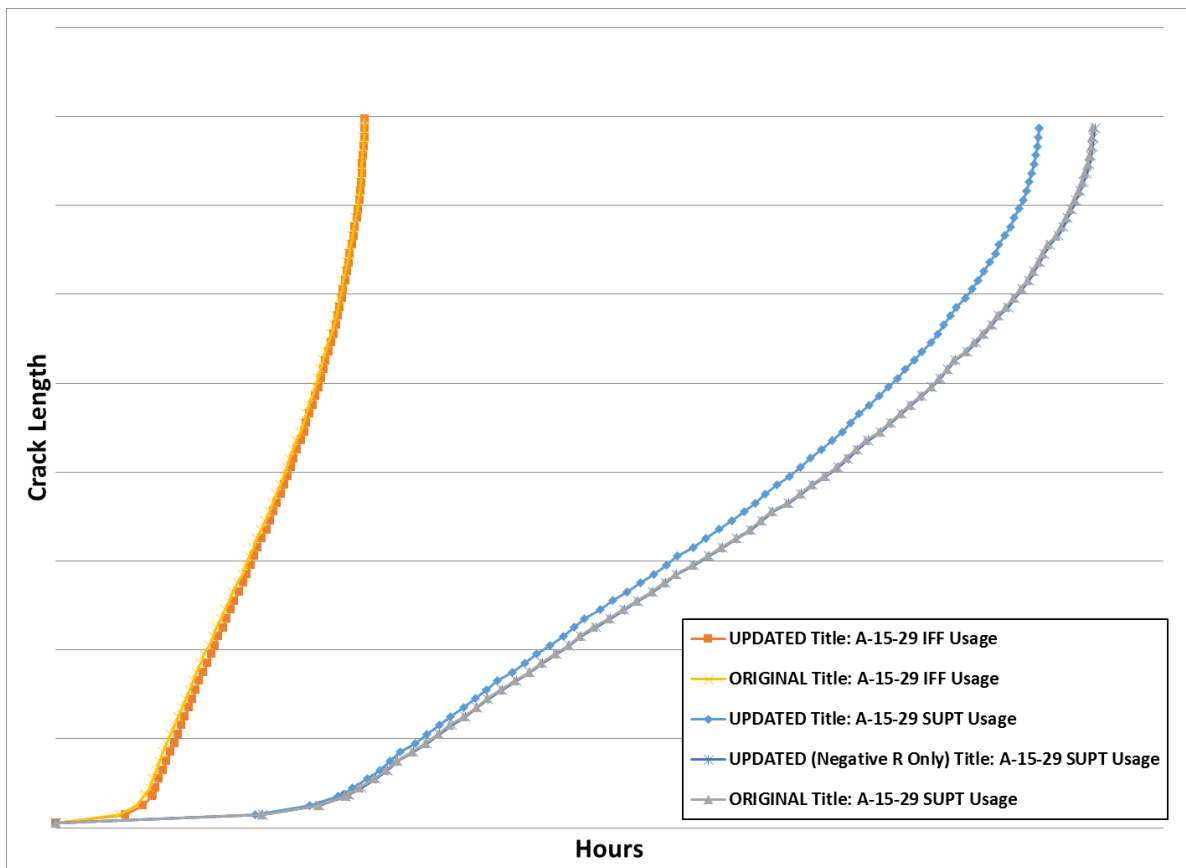


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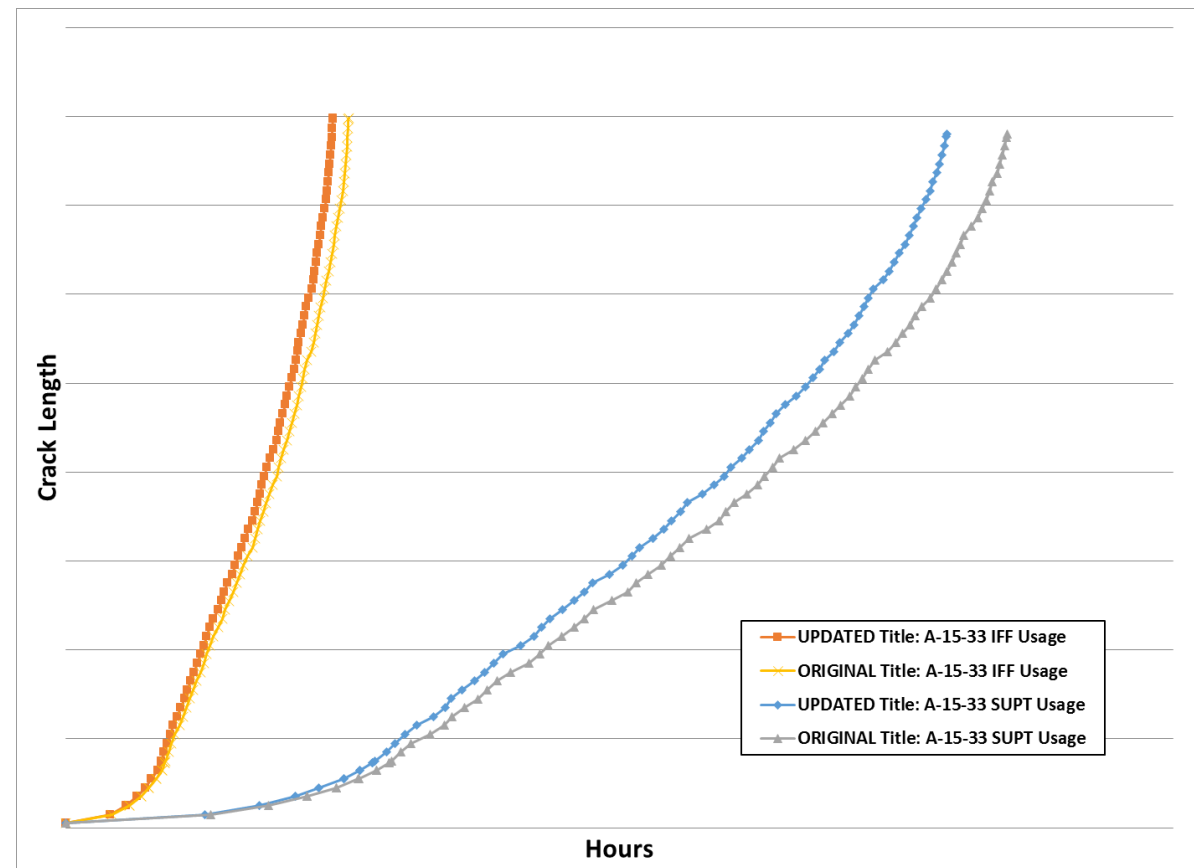
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A-15 Crack Growth Plot

A-15-29



A-15-33

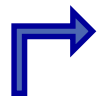


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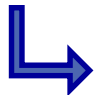
Summary

- ❑ New FCGR data developed to fill in gaps
- ❑ New fitting process incorporated
- ❑ Significant improvement in “fits” relative to test data
- ❑ Extrapolated negative R from original fits reasonable, however, Rlo significantly different for new fits (-0.3 → -0.1)
- ❑ Moderate damage tolerance and inspection interval results for FCLs updated



Greater accuracy of tabular fits with the inclusion of new negative R data mitigates “translation errors” across range of crack growth rates

Tradeoff



Across the board updates drive downstream changes to SOLR correlations, DTAs, and inspection intervals

Questions?

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